

<b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)	Docket Number (Optional) <b>39524.8200</b>		Application Number <b>TBA</b>	
	Applicant(s) <b>SHIH, Ying-Heng</b>			
	Filing Date <b>October 21, 2003</b>		Group Art Unit <b>TBA</b>	
	<b>U. S. PATENT DOCUMENTS</b>			

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
RSD	A	4,583,078	04/15/86	Shenoy, et al.			
RSD	B	5,912,908	06/15/99	Cesari, et al.			
RSD	C	5,970,104	10/19/99	Zhong, et al.			

FOREIGN PATENT DOCUMENTS								
REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation		
						YES	NO	

<b>OTHER DOCUMENTS</b> (Including Author, Title, Date, Pertinent Pages, Etc.)		
<b>RSD</b>	<b>D</b>	<b>ABRAMOVICI, M., et al.; "DIGITAL SYSTEMS TESTING AND TESTABLE DESIGN; IEEE Press, Piscataway, New Jersey, 1994, pgs. 432-439"</b>

EXAMINER <b>/R. Stephen Dildine/</b>	DATE CONSIDERED <b>05/30/2006</b>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	